

# RF Power Field Effect Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

Designed for broadband commercial and industrial applications with frequencies up to 1000 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 28 volt base station equipment.

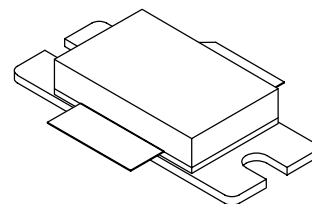
- Typical Single-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ} = 1400$  mA,  $P_{out} = 58$  Watts Avg., Full Frequency Band, 3GPP Test Model 1, 64 DPCH with 50% Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.  
Power Gain — 21.2 dB  
Drain Efficiency — 34%  
Device Output Signal PAR — 6.3 dB @ 0.01% Probability on CCDF  
ACPR @ 5 MHz Offset — -39.1 dBc in 3.84 MHz Channel Bandwidth
- Capable of Handling 10:1 VSWR, @ 32 Vdc, 880 MHz,  $P_{out} = 260$  W CW (3 dB Input Overdrive from Rated  $P_{out}$ ), Designed for Enhanced Ruggedness

### Features

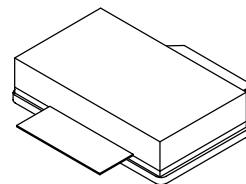
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32  $V_{DD}$  Operation
- Integrated ESD Protection
- Optimized for Doherty Applications
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

**MRFE6S9205HR3**  
**MRFE6S9205HSR3**

**880 MHz, 58 W AVG., 28 V**  
**SINGLE W-CDMA**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**



**CASE 465B-03, STYLE 1**  
**NI-880**  
**MRFE6S9205HR3**



**CASE 465C-02, STYLE 1**  
**NI-880S**  
**MRFE6S9205HSR3**

**Table 1. Maximum Ratings**

| Rating                               | Symbol    | Value        | Unit |
|--------------------------------------|-----------|--------------|------|
| Drain-Source Voltage                 | $V_{DSS}$ | -0.5, +66    | Vdc  |
| Gate-Source Voltage                  | $V_{GS}$  | -0.5, +12    | Vdc  |
| Storage Temperature Range            | $T_{stg}$ | - 65 to +150 | °C   |
| Case Operating Temperature           | $T_C$     | 150          | °C   |
| Operating Junction Temperature (1,2) | $T_J$     | 225          | °C   |

**Table 2. Thermal Characteristics**

| Characteristic                                                                                            | Symbol          | Value (2,3)  | Unit |
|-----------------------------------------------------------------------------------------------------------|-----------------|--------------|------|
| Thermal Resistance, Junction to Case<br>Case Temperature 80°C, 202 W CW<br>Case Temperature 77°C, 58 W CW | $R_{\theta JC}$ | 0.27<br>0.33 | °C/W |

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Tools (Software & Tools)/Calculators to access the MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**Table 3. ESD Protection Characteristics**

| Test Methodology                      | Class              |
|---------------------------------------|--------------------|
| Human Body Model (per JESD22-A114)    | Class 1C (Minimum) |
| Machine Model (per EIA/JESD22-A115)   | Class B (Minimum)  |
| Charge Device Model (per JESD22-C101) | Class IV (Minimum) |

**Table 4. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

**Off Characteristics**

|                                                                                                   |           |   |   |    |                 |
|---------------------------------------------------------------------------------------------------|-----------|---|---|----|-----------------|
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 66\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | — | — | 10 | $\mu\text{Adc}$ |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | — | — | 1  | $\mu\text{Adc}$ |
| Gate-Source Leakage Current<br>( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )              | $I_{GSS}$ | — | — | 10 | $\mu\text{Adc}$ |

**On Characteristics**

|                                                                                                                |              |     |     |     |     |
|----------------------------------------------------------------------------------------------------------------|--------------|-----|-----|-----|-----|
| Gate Threshold Voltage<br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 600\text{ }\mu\text{Adc}$ )                      | $V_{GS(th)}$ | 1.4 | 2.1 | 2.9 | Vdc |
| Gate Quiescent Voltage<br>( $V_{DD} = 28\text{ Vdc}$ , $I_D = 1400\text{ mAdc}$ , Measured in Functional Test) | $V_{GS(Q)}$  | 2.2 | 2.9 | 3.7 | Vdc |
| Drain-Source On-Voltage<br>( $V_{GS} = 10\text{ Vdc}$ , $I_D = 4.2\text{ Adc}$ )                               | $V_{DS(on)}$ | 0.1 | 0.2 | 0.3 | Vdc |

**Dynamic Characteristics <sup>(1)</sup>**

|                                                                                                                       |           |   |      |   |    |
|-----------------------------------------------------------------------------------------------------------------------|-----------|---|------|---|----|
| Reverse Transfer Capacitance<br>( $V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ ) | $C_{rss}$ | — | 1.63 | — | pF |
| Output Capacitance<br>( $V_{DS} = 28\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )           | $C_{oss}$ | — | 590  | — | pF |
| Input Capacitance<br>( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)            | $C_{iss}$ | — | 491  | — | pF |

**Functional Tests** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 1400\text{ mA}$ ,  $P_{out} = 58\text{ W Avg. W-CDMA}$ ,  $f = 880\text{ MHz}$ , Single-Carrier W-CDMA, 3.84 MHz Channel Bandwidth Carrier. ACPR measured in 3.84 MHz Channel Bandwidth @ 5 MHz Offset. PAR = 7.5 dB @ 0.01% Probability on CCDF.

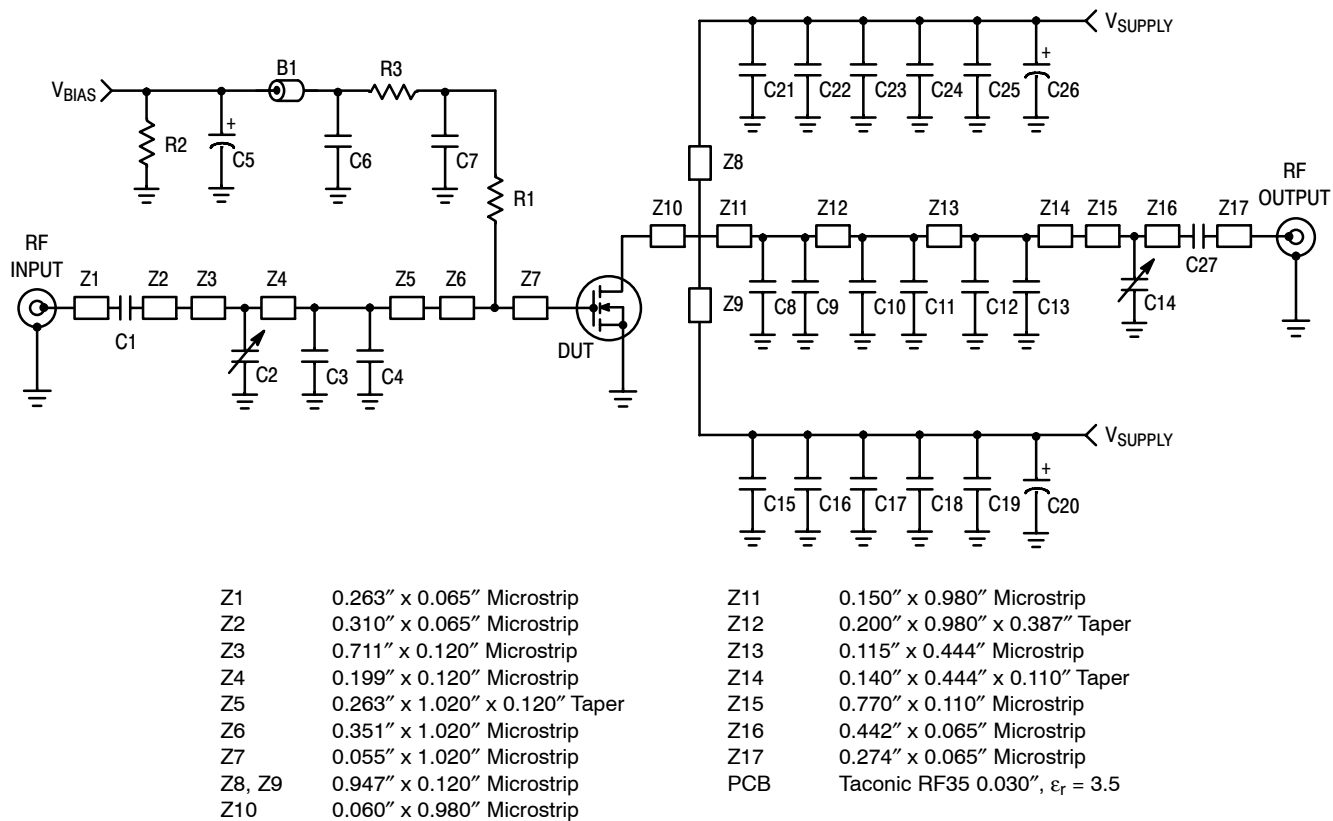
|                                                          |          |    |       |       |     |
|----------------------------------------------------------|----------|----|-------|-------|-----|
| Power Gain                                               | $G_{ps}$ | 20 | 21.2  | 23    | dB  |
| Drain Efficiency                                         | $\eta_D$ | 32 | 34    | —     | %   |
| Output Peak-to-Average Ratio @ 0.01% Probability on CCDF | PAR      | 6  | 6.3   | —     | dB  |
| Adjacent Channel Power Ratio                             | ACPR     | —  | -39.1 | -37.5 | dBc |
| Input Return Loss                                        | IRL      | —  | -12.5 | -8.5  | dB  |

1. Part is internally matched on input.

(continued)

**Table 4. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$  unless otherwise noted) (continued)

| Characteristic                                                                                                                                                                                                    | Symbol           | Min | Typ   | Max | Unit   |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------|-----|-------|-----|--------|
| <b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$ , $I_{DQ} = 1400\text{ mA}$ , 865-900 MHz Bandwidth                                                               |                  |     |       |     |        |
| Video Bandwidth @ 220 W PEP $P_{out}$ where $IM3 = -30\text{ dBc}$<br>(Tone Spacing from 100 kHz to VBW) $\Delta IMD3 = IMD3 @ \text{VBW}$<br>frequency - $IMD3 @ 100\text{ kHz} < 1\text{ dBc}$ (both sidebands) | VBW              | —   | 10    | —   | MHz    |
| Gain Flatness in 35 MHz Bandwidth @ $P_{out} = 58\text{ W Avg.}$                                                                                                                                                  | $G_F$            | —   | 0.315 | —   | dB     |
| Average Deviation from Linear Phase in 35 MHz Bandwidth<br>@ $P_{out} = 200\text{ W CW}$                                                                                                                          | $\Phi$           | —   | 0.59  | —   | °      |
| Average Group Delay @ $P_{out} = 200\text{ W CW}$ , $f = 880\text{ MHz}$                                                                                                                                          | Delay            | —   | 4.27  | —   | ns     |
| Part-to-Part Insertion Phase Variation @ $P_{out} = 200\text{ W CW}$ ,<br>$f = 880\text{ MHz}$ , Six Sigma Window                                                                                                 | $\Delta\Phi$     | —   | 26.3  | —   | °      |
| Gain Variation over Temperature<br>( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )                                                                                                                                 | $\Delta G$       | —   | 0.016 | —   | dB/°C  |
| Output Power Variation over Temperature<br>( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )                                                                                                                         | $\Delta P_{1dB}$ | —   | 0.006 | —   | dBm/°C |



**Figure 1. MRFE6S9205HR3(HSR3) Test Circuit Schematic**

**Table 5. MRFE6S9205HR3(HSR3) Test Circuit Component Designations and Values**

| Part                             | Description                               | Part Number        | Manufacturer     |
|----------------------------------|-------------------------------------------|--------------------|------------------|
| B1                               | Short RF Bead                             | 2743019447         | Fair-Rite        |
| C1, C7, C15, C16, C21, C22, C27  | 39 pF Chip Capacitors                     | ATC100B390JT500XT  | ATC              |
| C2, C14                          | 0.8-8.0 pF Variable Capacitors, Gigatrim  | 27291SL            | Johanson         |
| C3, C4                           | 5.1 pF Chip Capacitors                    | ATC100B5R1JT500XT  | ATC              |
| C5                               | 33 $\mu$ F, 25 V Electrolytic Capacitor   | EMVY350ADA330MF55G | Nippon Chemi-Con |
| C6, C17, C18, C19, C23, C24, C25 | 10 $\mu$ F, 50 V Chip Capacitors          | GRM55DR61H106KA88B | Murata           |
| C8, C9, C10, C11, C12, C13       | 6.8 pF Chip Capacitors                    | ATC100B6R8JT500XT  | ATC              |
| C20, C26                         | 470 $\mu$ F, 63 V Electrolytic Capacitors | EKME630ELL471MK255 | United Chemi-Con |
| R1, R3                           | 3.3 $\Omega$ , 1/3 W Chip Resistors       | CRCW12103R30FKEA   | Vishay           |
| R2                               | 2.2 k $\Omega$ , 1/4 W Chip Resistor      | CRCW12062K20FKEA   | Vishay           |

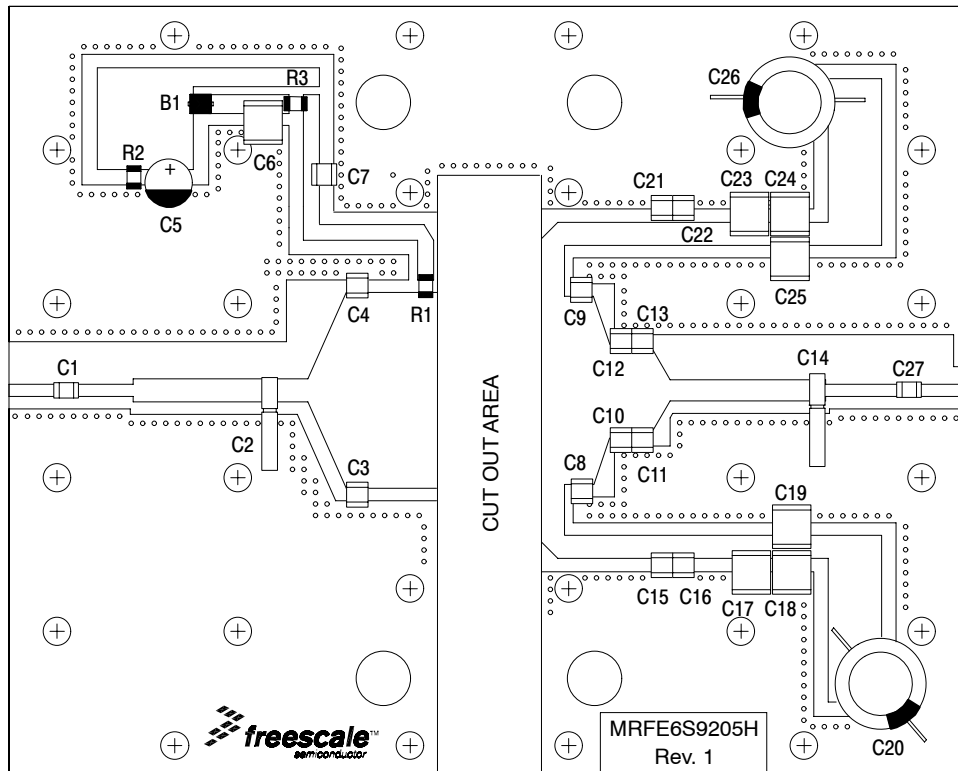
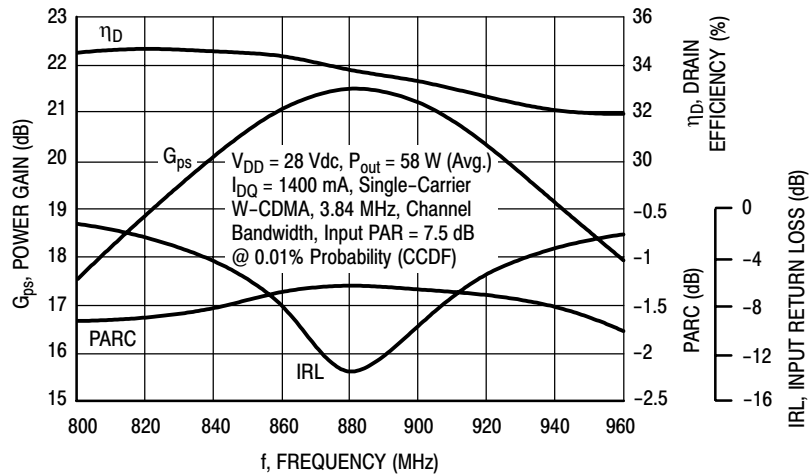
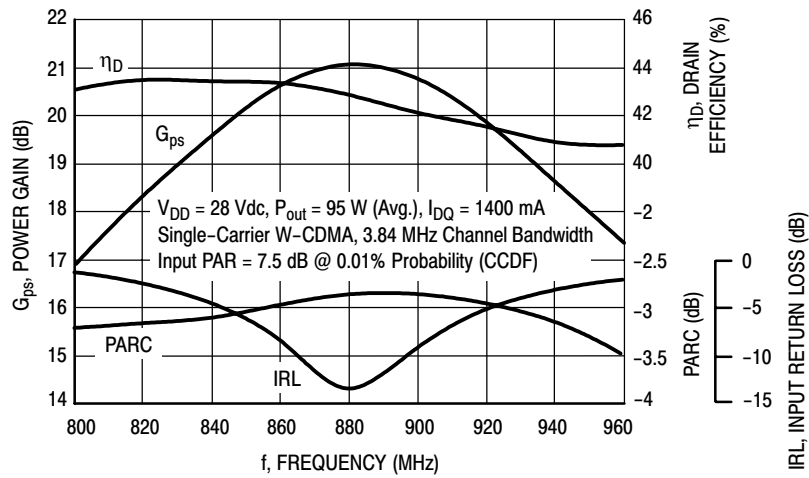


Figure 2. MRFE6S9205HR3(HSR3) Test Circuit Component Layout

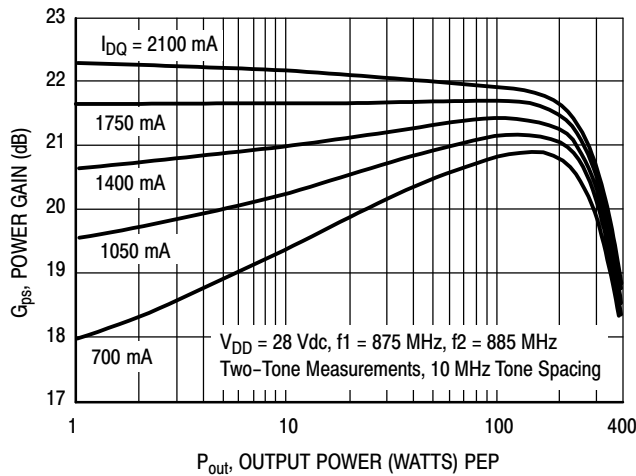
## TYPICAL CHARACTERISTICS



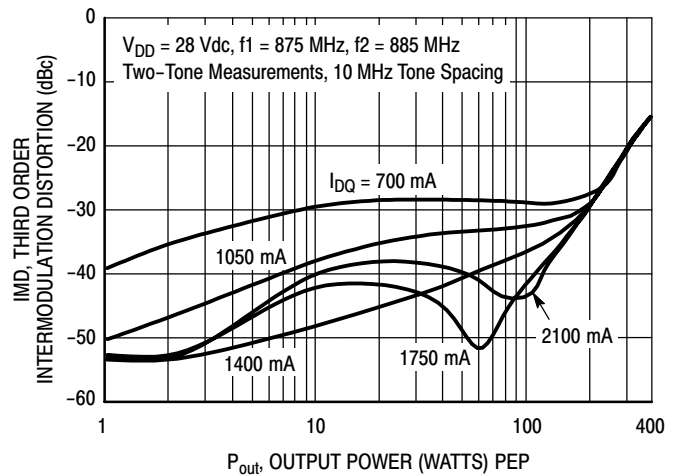
**Figure 3. Output Peak-to-Average Ratio Compression (PARC)  
Broadband Performance @  $P_{out} = 58$  Watts Avg.**



**Figure 4. Output Peak-to-Average Ratio Compression (PARC)  
Broadband Performance @  $P_{out} = 95$  Watts Avg.**

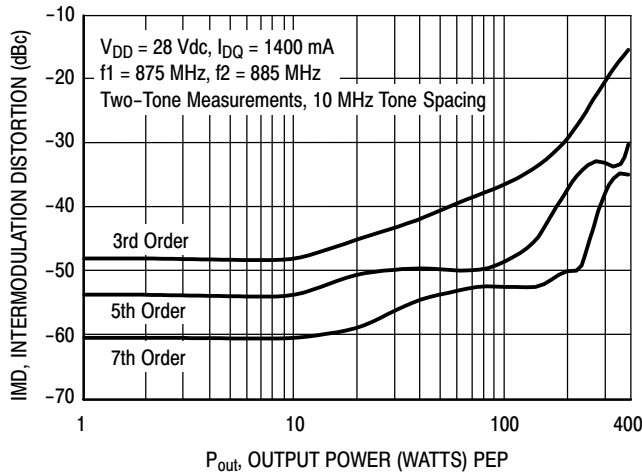


**Figure 5. Two-Tone Power Gain versus  
Output Power**

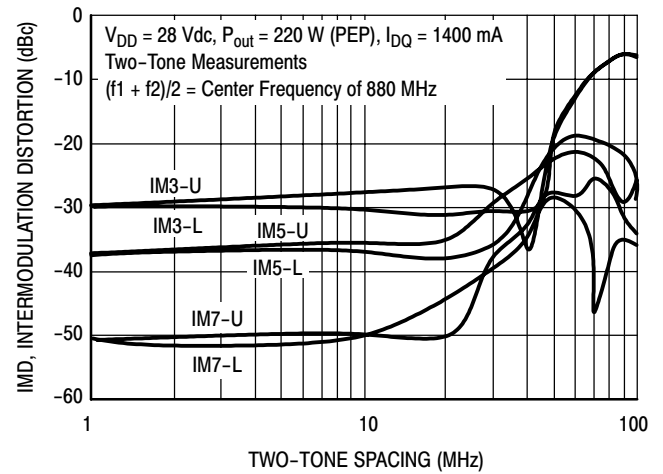


**Figure 6. Third Order Intermodulation Distortion  
versus Output Power**

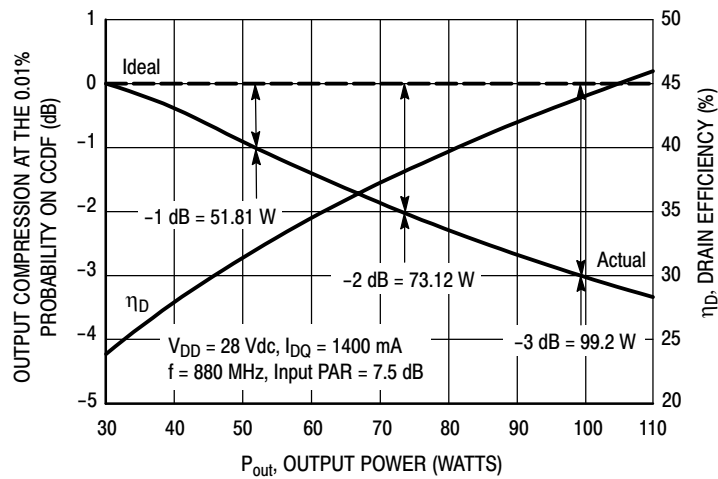
## TYPICAL CHARACTERISTICS



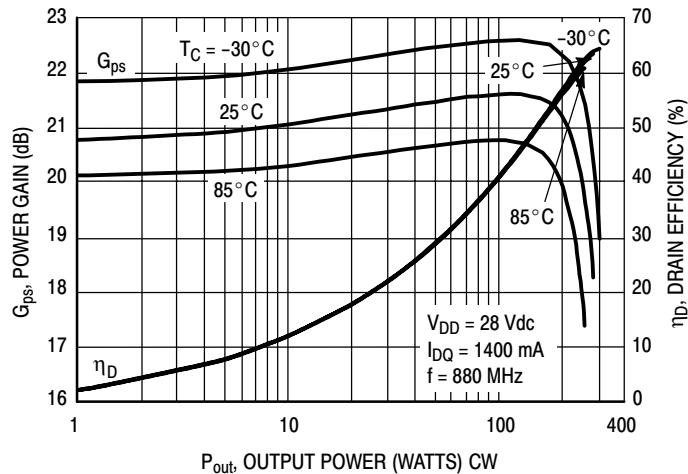
**Figure 7. Intermodulation Distortion Products versus Output Power**



**Figure 8. Intermodulation Distortion Products versus Output Power**

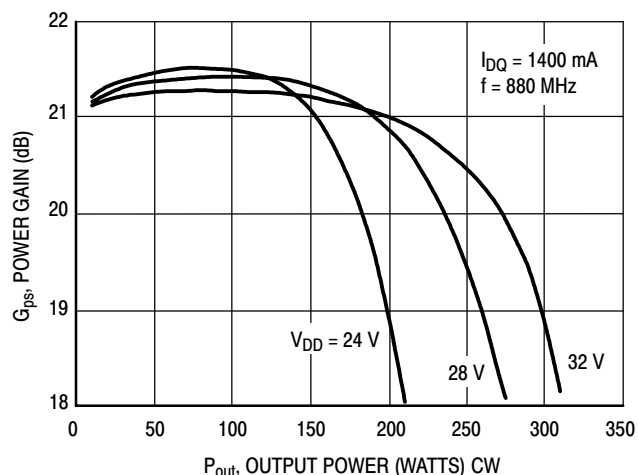


**Figure 9. Output Peak-to-Average Ratio Compression (PARC) versus Output Power**

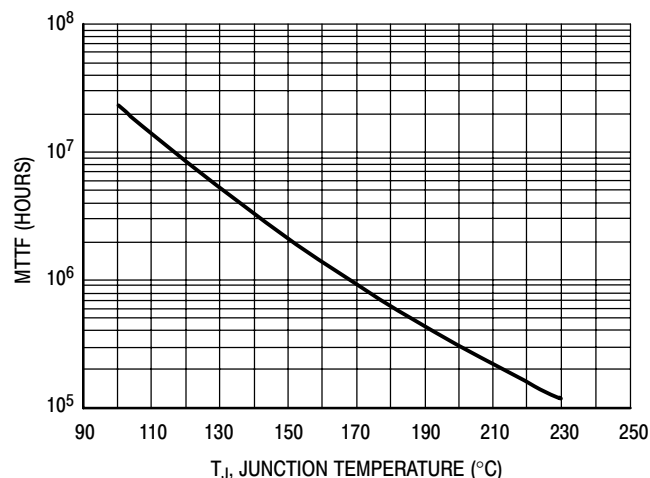


**Figure 10. Power Gain and Drain Efficiency versus CW Output Power**

## TYPICAL CHARACTERISTICS



**Figure 11. Power Gain versus Output Power**

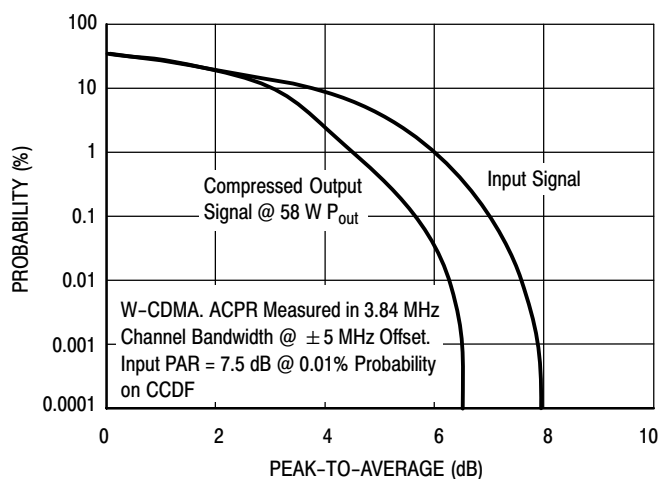


This above graph displays calculated MTTF in hours when the device is operated at  $V_{DD} = 28$  Vdc,  $P_{out} = 58$  W Avg., and  $\eta_D = 34\%$ .

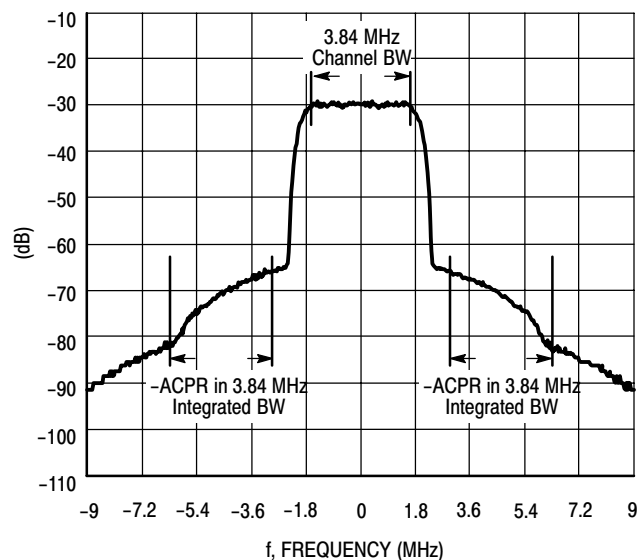
MTTF calculator available at <http://www.freescale.com/rf>. Select Tools (Software & Tools)/Calculators to access MTTF calculators by product.

**Figure 12. MTTF versus Junction Temperature**

## W-CDMA TEST SIGNAL

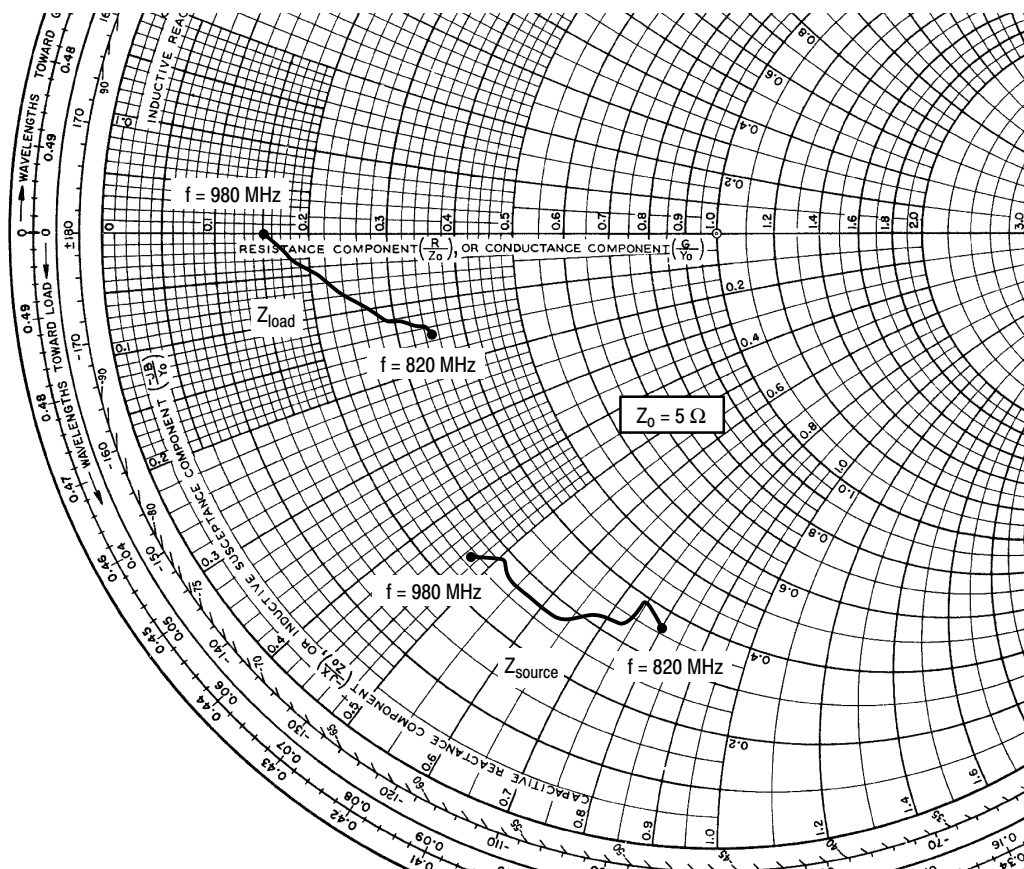


**Figure 13. CCDF W-CDMA 3GPP, Test Model 1, 64 DPCH, 50% Clipping, Single-Carrier Test Signal**



**Figure 14. Single-Carrier W-CDMA Spectrum**





$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 1400 \text{ mA}$ ,  $P_{out} = 58 \text{ W Avg.}$

| f<br>MHz | $Z_{source}$<br>$\Omega$ | $Z_{load}$<br>$\Omega$ |
|----------|--------------------------|------------------------|
| 820      | $1.80 - j4.00$           | $1.75 - j0.73$         |
| 840      | $1.88 - j3.76$           | $1.68 - j0.69$         |
| 860      | $1.64 - j3.65$           | $1.57 - j0.64$         |
| 880      | $1.54 - j3.41$           | $1.44 - j0.58$         |
| 900      | $1.35 - j3.13$           | $1.33 - j0.51$         |
| 920      | $1.37 - j2.89$           | $1.21 - j0.40$         |
| 940      | $1.37 - j2.66$           | $1.07 - j0.27$         |
| 960      | $1.39 - j2.53$           | $0.92 - j0.13$         |
| 980      | $1.25 - j2.33$           | $0.74 + j0.01$         |

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.

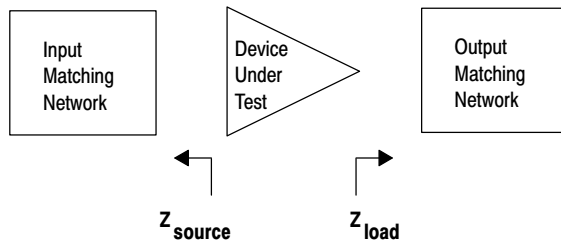
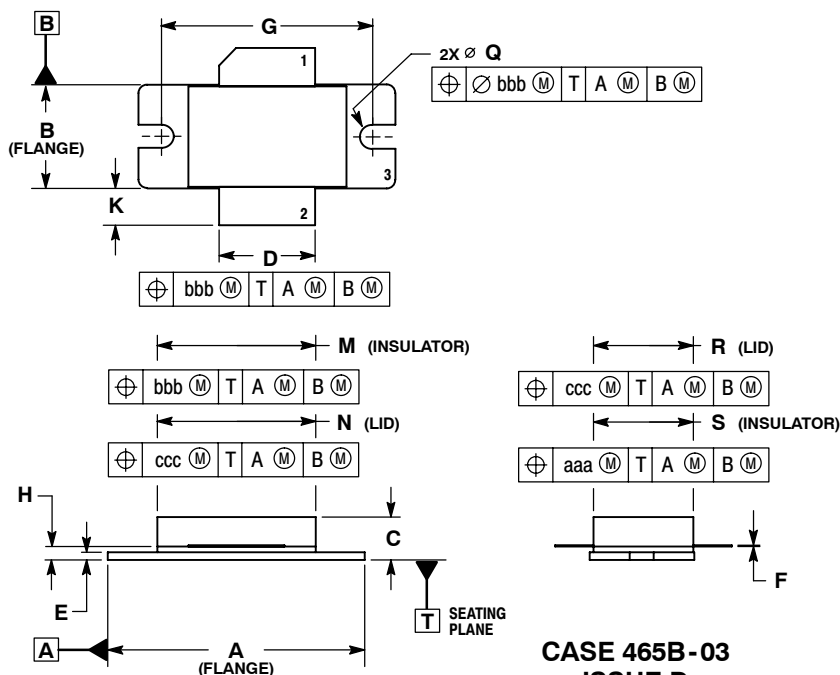


Figure 15. Series Equivalent Source and Load Impedance

## PACKAGE DIMENSIONS

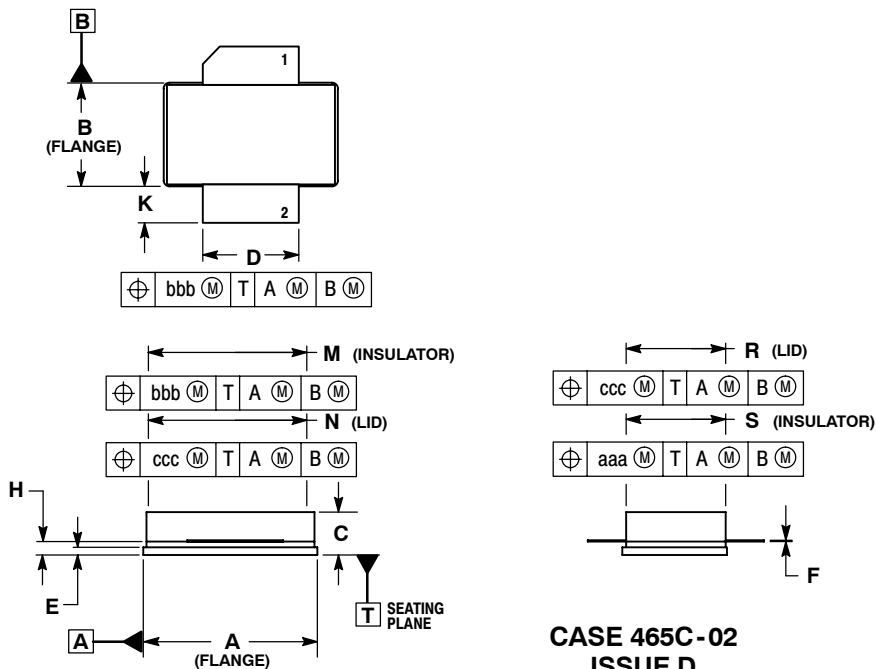


**CASE 465B-03**  
**ISSUE D**  
**NI-880**  
**MRFE6S9205HR3**

- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
  2. CONTROLLING DIMENSION: INCH.
  3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.
  4. DELETED

| DIM | INCHES |       | MILLIMETERS |       |
|-----|--------|-------|-------------|-------|
|     | MIN    | MAX   | MIN         | MAX   |
| A   | 1.335  | 1.345 | 33.91       | 34.16 |
| B   | 0.535  | 0.545 | 13.6        | 13.8  |
| C   | 0.147  | 0.200 | 3.73        | 5.08  |
| D   | 0.495  | 0.505 | 12.57       | 12.83 |
| E   | 0.035  | 0.045 | 0.89        | 1.14  |
| F   | 0.003  | 0.006 | 0.08        | 0.15  |
| G   | 1.100  | BSC   | 27.94       | BSC   |
| H   | 0.057  | 0.067 | 1.45        | 1.70  |
| K   | 0.170  | 0.210 | 4.32        | 5.33  |
| M   | 0.872  | 0.888 | 22.15       | 22.55 |
| N   | 0.871  | 0.889 | 19.30       | 22.60 |
| Q   | 0.118  | 0.138 | 3.00        | 3.51  |
| R   | 0.515  | 0.525 | 13.10       | 13.30 |
| S   | 0.515  | 0.525 | 13.10       | 13.30 |
| aaa | 0.007  | REF   | 0.178       | REF   |
| bbb | 0.010  | REF   | 0.254       | REF   |
| ccc | 0.015  | REF   | 0.381       | REF   |

STYLE 1:  
 PIN 1. DRAIN  
 2. GATE  
 3. SOURCE



**CASE 465C-02**  
**ISSUE D**  
**NI-880S**  
**MRFE6S9205HSR3**

- NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
  2. CONTROLLING DIMENSION: INCH.
  3. DIMENSION H IS MEASURED 0.030 (0.762) AWAY FROM PACKAGE BODY.

| DIM | INCHES |       | MILLIMETERS |       |
|-----|--------|-------|-------------|-------|
|     | MIN    | MAX   | MIN         | MAX   |
| A   | 0.905  | 0.915 | 22.99       | 23.24 |
| B   | 0.535  | 0.545 | 13.60       | 13.80 |
| C   | 0.147  | 0.200 | 3.73        | 5.08  |
| D   | 0.495  | 0.505 | 12.57       | 12.83 |
| E   | 0.035  | 0.045 | 0.89        | 1.14  |
| F   | 0.003  | 0.006 | 0.08        | 0.15  |
| H   | 0.057  | 0.067 | 1.45        | 1.70  |
| K   | 0.170  | 0.210 | 4.32        | 5.33  |
| M   | 0.872  | 0.888 | 22.15       | 22.55 |
| N   | 0.871  | 0.889 | 19.30       | 22.60 |
| R   | 0.515  | 0.525 | 13.10       | 13.30 |
| S   | 0.515  | 0.525 | 13.10       | 13.30 |
| aaa | 0.007  | REF   | 0.178       | REF   |
| bbb | 0.010  | REF   | 0.254       | REF   |
| ccc | 0.015  | REF   | 0.381       | REF   |

STYLE 1:  
 PIN 1. DRAIN  
 2. GATE  
 3. SOURCE

## PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

## REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date      | Description                                                                       |
|----------|-----------|-----------------------------------------------------------------------------------|
| 0        | Oct. 2007 | <ul style="list-style-type: none"> <li>• Initial Release of Data Sheet</li> </ul> |

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ARCO Tower 15F  
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Tokyo 153-0064  
Japan  
0120 191014 or +81 3 5437 9125  
[support.japan@freescale.com](mailto:support.japan@freescale.com)

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